



Title of Change:	P2 MC34063xx/ MC33063xx SOIC8 Test Enablement at ASEKS (Non Turnkey)	
Proposed first ship date:	27 June 2018	
Contact information:	Contact your local ON Semiconductor Sales Office or <Julius.Javier@onsemi.com>	
Samples:	Contact your local ON Semiconductor Sales Office	
Additional Reliability Data:	Contact your local ON Semiconductor Sales Office	
Type of notification:	This is a Final Product/Process Change Notification (FPCN) sent to customers. FPCNs are issued 90 days prior to implementation of the change. ON Semiconductor will consider this change accepted, unless an inquiry is made in writing within 30 days of delivery of this notice. To do so, contact <PCN.Support@onsemi.com>	
Change Part Identification:	Affected products will be identified with date codes.	
Change category:	<input type="checkbox"/> Wafer Fab Change <input type="checkbox"/> Assembly Change <input checked="" type="checkbox"/> Test Change <input type="checkbox"/> Other _____	
Change Sub-Category(s):	<input checked="" type="checkbox"/> Manufacturing Site Change/Addition <input type="checkbox"/> Material Change <input type="checkbox"/> Datasheet/Product Doc change <input checked="" type="checkbox"/> Manufacturing Process Change <input type="checkbox"/> Product specific change <input type="checkbox"/> Shipping/Packaging/Marking <input type="checkbox"/> Other: _____	
Sites Affected:	ON Semiconductor Sites: ON Semiconductor, Carmona, Philippines.	External Foundry/Subcon Sites: ASEKS, Qiandeng, Kunshan, Jiangsu Province, P.R.China
Description and Purpose:		
Test capacity expansion. P2 BU to expand SOIC8 test capacity. This to add capacity on our current and future business.		
Before Change Description	After Change Description	
ON Semiconductor, Carmona, Philippines. Tester Type : DTS Handler Type : Ismeca NX32 Number of site: Single	ON Semiconductor, Carmona, Philippines Tester Type : DTS Handler Type : Ismeca NX32 Number of site: Single	
	ASEKS, Qiandeng, Kunshan, Jiangsu Province, P.R. China Tester Type : 8T861 Handler Type : CT928/MT9320 Number of site : Dual	



Reliability Data Summary:

Reliability not required for FINAL TEST Transfer.

Electrical Characteristic Summary:

HGRR/IGRR and Test correlation meet all the requirements.

List of Affected Standard Parts:

Part Number	Qualification Vehicle
MC33063ADR2G	MC33063ADR2G
MC34063ADR2G	MC34063ADR2G
MC33063ADG	MC33063ADG
MC34063ADG	MC34063ADG



Appendix A: Changed Products

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Product	Customer Part Number	Qualification Vehicle
MC33063ADG		MC33063ADG
MC33063ADR2G		MC33063ADR2G
MC34063ADG		MC34063ADG
MC34063ADR2G		MC34063ADR2G